

N-Channel Enhancement Mode Field Effect Transistor

FEATURES

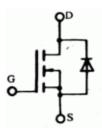
- Super high dense cell design for low RDS(ON)
- Rugged and reliable
- Simple drive requirement
- SOT-23 package

PRODUCT SUMMARY					
V _{DSS}	oss I_D $R_{DS(ON)}$ $(m \Omega)$ Typ				
20V	3.6A	33 @ VGS=4.5V			
		52 @ VGS=2.5V			



NOTE: The Si2300 is available in a lead-free package





ABSOLUTE MAXIUM RATINGS (Ta=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	20	V
Gate-Source Voltage	VGS	±8	V
Drain Current-Continuous ^a @Tj=125 ℃	ID	3.6	A
- Pulse d^{b}	Ідм	12	A
Drain-source Diode Forward Current ^a	Is	1.25	A
Maximum Power Dissipation ^a	PD	1.25	W
Operating Junction and Storage Temperature Range	TJ,Tstg	-55 to 150	$^{\circ}$

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to Ambient ^a	Rth JA	100	°C/W

Si2300



ELECTRICAL CHARACTERISTICS (Ta=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BVDSS	Vgs=0V,Id=250µA	20			V	
Zero Gate Voltage Drain Current	IDSS	Vds=16V,Vgs=0V			1	μА	
Gate-Body Leakage	Igss	V _G s=±8V,V _D s=0V			±100	nA	
ON CHARACTERITICS							
Gate Threshold Voltage	Vgs(th)	$V_{DS}=V_{GS},I_{D}=250\mu A$	0.5	0.8	1.5	V	
Drain-Source On-State Resistance	Rds(on)	Vgs=4.5V,Id=2.8A		33	45	- m Ω	
Drain-Source On-State Resistance	KDS(ON)	Vgs=2.5V,ID=2.0A		52	60		
Forward Transconductance	gFS	Vgs=7V,Id=5A		5		S	
DAYNAMIC CHARACTERISTICS							
Input Capacitance	Ciss	Vds=10V,Vgs=0V f=1.0MHz		608		pF	
Output Capacitance	Coss			115		pF	
Reverse Transfer Capacitance	Crss			86		pF	
SWITCHING CHARACTERISISTICS							
Turn-On Delay Time	td(ON)	VDD=10V ID=3.6A, VGEN=4.5V RL=10ohm RGEN=10ohm		10		ns	
Rise Time	tr			14		ns	
Turn-Off Delay Time	tD(OFF)			39		ns	
Fall Time	tf			26		ns	
Total Gate Charge	Q g	Vds=10V,Id=1A Vgs=4.5V		9.2		nC	
Gate-Source Charge	Qgs			1.6		nC	
Gate-Drain Charge	Qgd			2.6		nC	

2

Si2300

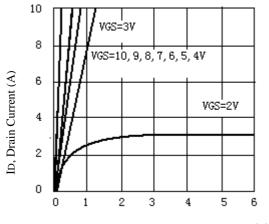


ELECTRICAL CHARACTERICS (TA=25°C unless otherwise noted)

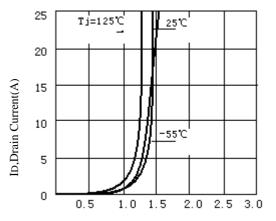
Parameter	Symbol	Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode Forward Voltage	V _{SD}	Vgs=0V,Is=1.25A		0.84	1.3	V

Notes

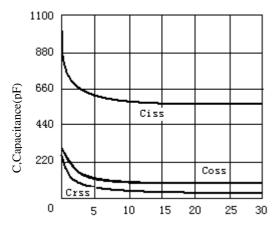
- a. Surface Mounted on FR4 Board, t≤10sec
- b. Pulse Test: Pulse Width ≤ 300Us, Duty ≤ 2%
- c. Guaranteed by design, not subject to production testing.



VDS, Drain-to-Source Voltage (V) Figure 1.Output Characteristics



Vcs, Gate-to-source Voltage (V) Figure 2. Transfer Characteristics



VGS, Drain-to Source Voltage Figure3. Capacitance

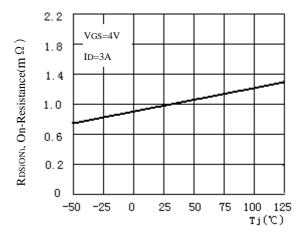
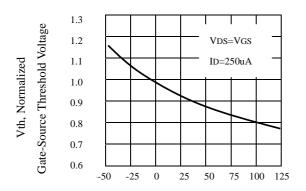


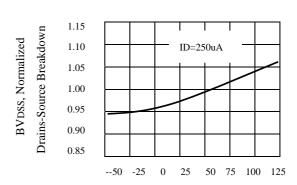
Figure 4. On-Resistance Variation with Temperature

Si2300

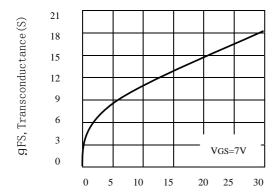




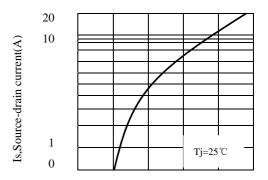
 $\label{eq:Tj.Junction} Temperature({}^{\circ}\mathbb{C})$ Figure 5. Gate Threshold Variation With Temperature



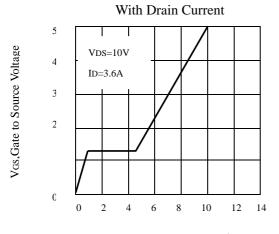
Tj, .Junction Temperature ($^{\circ}$ C)
Figure 6.Breakdown Voltage Variation
With Temperature



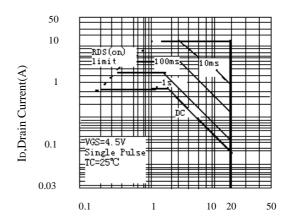
IDS, Drain-Source Current (A) Figure 7. Transconductance Variation



Vsp, Body Diode Forward Voltage Figure8.Body Diode Forward Voltage Variation with Source Current



Qg, Total Gate Charge(nC)
Figure 9. Gate Charge



VDS, Drain-Source Voltage(V)
Figure 10.Maximum Safe Operating Area